

Notice of References Cited

Application/Control No.

10/550,546

Applicant(s)/Patent Under
Reexamination
WATANABE ET AL.

Examiner

AMENE S. BAYOU

Art Unit

3746

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,800,147	09-1998	Arai et al.	417/269
*	B	US-4,544,332	10-1985	Shibuya, Tsunenori	417/269
*	C	US-4,715,790	12-1987	Iijima et al.	417/269
*	D	US-4,544,332	10-1985	Shibuya, Tsunenori	417/269
*	E	US-4,768,928	09-1988	Miller, Gary T.	417/269
*	F	US-5,100,306	03-1992	Moran et al.	417/571
*	G	US-5,765,996	06-1998	Fujii et al.	417/269
*	H	US-5,800,147	09-1998	Arai et al.	417/269
*	I	US-6,575,708	06-2003	DeWispelaere, Bradley J.	417/269
*	J	US-6,318,980	11-2001	Kurihara et al.	417/571
*	K	US-6,382,938	05-2002	Murao et al.	417/540
*	L	US-6,296,457	10-2001	Shintoku et al.	417/312
*	M	US-6,568,924	05-2003	Kawamura et al.	417/540

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

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